

Status, plans, and open issues

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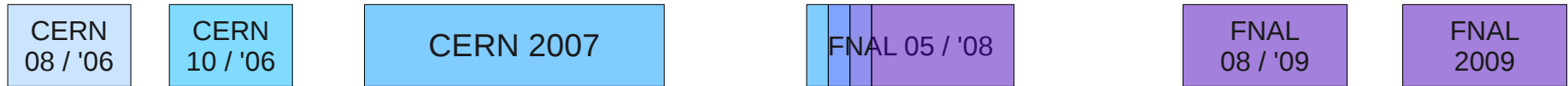
HCal Main Mtg.

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- New version of **IntegratedHcalCalibrationProcessor** with auto temp. correction developed, tested, and released (calice_reco)
- Requires new storage and helper classes (calice_userlib)
- Update to CVS HEAD (tags to come...) for
 - calice_userlib
 - calice_reco
 - calice_run (for steering files)
- New web page for version dependencies:
<https://twiki.cern.ch/twiki/bin/view/CALICE/SoftwareVersions>
- Beware of upstream dependency:
 - ilcsoft v01-06 plus LCCD v00-05-pre (waiting for ilcsoft v01-07)
 - appropriate ilcinstall script for CALICE on TWiki:
<https://twiki.cern.ch/twiki/bin/view/CALICE/SoftwareInstallation>

Ingredients for hit reco

- New calibration scheme requires 4 calibration measurements:
 - A^0 - Mip calibrations per voltage setting
 - dA/dT - Mip temperature slopes for auto T correction
 - G^0 - dG/dT - Gain offsets and T-slopes per voltage setting
 - IC - intercalibration (universal set, averaged and cleaned)
- dA/dU - Mip voltage slopes for 'manual' extrapolation in case A^0 is not available for certain voltage setting
- Uncertainties on green inputs affect full calibrated amplitude, uncertainties on blue inputs only the saturation correction factor
- Alignment requires three steps
 - cell-to-module (blue-print) - good
 - module-to-stack (layer and staggering) - good for 0^0
 - stack-to-world (movement and rotation) - not good



- Changed color = (partially) changed voltage
 ⇒ require at least 6 sets of Mip and Gain constants and slopes
 (IC does not change with voltage)
- Currently database status:
 - A^0 from CERN 2007, valid from 2006-09 !!! voltage !!!
 - dA/dT from CERN 2007, valid from 2006-09
 - G^0 from CERN 2007, valid from 2006-09 !!! voltage !!!
 - dG/dT from CERN 2007, valid from 2006-09
 - IC from CERN 2007 topped up with FNAL 2008, valid 2006-09
- Technically everything runs, good for CERN 2007 only

- Muon data fitting:
 - A^0 fits on small set of muon runs established with some hands-on work. Fit quality checks to be automated
 - dA/dT has only been extracted once and never really been cross checked thoroughly
 - new diploma student from Prague: Boris Bulanek
- Gain data fitting:
 - Peak fits for individual gain runs available since long
 - Simultaneous G^0 and dG/dT fits on many gain runs established with some back-and-forth between different people
- IC extraction for individual Pm/CmVCalibScans established, requires (manual) clean-up

- Need tracking to work before 'global' alignment, which is slowly improving
- Summer student at Hamburg to work on tools to align HCal-in-world and module-in-HCal using muon data

- Get reasonable constants for all periods
- Analyze as many muon runs as possible, at least one set per voltage setting. More automated tools necessary for 'mass production' and fit quality checks?
- Cross checks on dA/dT measurement (and dA/dU while at it) Re-fitting A^0 necessary (Gaussian vs. LanGau fit)?
- Cross check G^0 and dG/dT slope fits, quality criteria
- Closer look at IC - understand first principles rather than dubious selection of acceptable measurements
- Study influence of electronics (chip exchange)
- Documentation and tool repository